Search Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/697,005	NOZAKI ET AL.	
Examiner	Art Unit	
Kim T. Nguyen	3713	

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Class	Subclass	Date	Examiner
463	20, 30-31	3/3/2006	KN

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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EAST text search	3/3/2006	KN
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